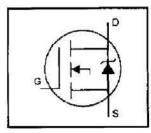
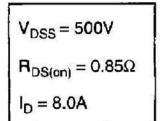


IRF840LCPbF

HEXFET® Power MOSFET

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30V Vgs Rating
- Reduced Ciss, Coss, Crss
- Extremely High Frequency Operation
- Repetitive Avalanche Rated
- Lead-Free

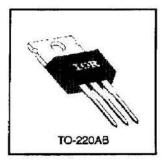




Description

This new series of Low Charge HEXFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing the new LCDMOS technology, the device improvements are achieved without added product cost, allowing for reduced gate drive requirements and total system savings. In addition, reduced switching losses and improved efficiency are achievable in a variety of high frequency applications. Frequencies of a few MHz at high current are possible using the new Low Charge MOSFETs.

These device improvements combined with the proven ruggedness and reliability that are characteristic of HEXFETs offer the designer a new standard in power transistors for switching applications.



Absolute Maximum Ratings

	Parameter	Max.	Units
lo @ Tc = 25°C	Continuous Drain Current, VGS @ 10 V	8.0	
to @ Tc = 100°C	Continuous Drain Current, V _{GS} @ 10 V	5.1	Α
l _{DM}	Pulsed Drain Current ①	28	
Po @ To = 25°C	Power Dissipation	125	W
200	Linear Derating Factor	1.0	W/°C
Vos	Gate-to-Source Voltage	=30	V
Eas ,	Single Pulse Avalanche Energy @	510	mJ
AR	Avalanche Current ①	8.0	Α
EAR	Repetitive Avalanche Energy ①	13	mJ
dv/dt	Peak Dioce Recovery dv/dt ③	3.5	V/ns
Т.,	Operating Junction and	-55 to +150	
Tstg	Storage Temperature Range		_
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf-in (1.1 N-m)	

Thermal Resistance

- 0) 337	Parameter	Min.	Тур.	Max.	Units
Reuc	Junction-to-Case	_		1.0	T.
Recs	Case-to-Sink, Flat, Greased Surface	-	0.50	-	°C/W
ROM	Junction-to-Ambient	-		62	

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions	
Vienos	Drain-to-Source Breakdown Voltage	500			٧	V _{GS} =0V, I _D = 250μA	
ΔV _{BR)DSS} /ΔTJ	Breakdown Voltage Temp. Coefficient	_	0.63		V/°C	Reference to 25°C, Ip= ImA	
Rosioni	Static Drain-to-Source On-Resistance	1 -	I =	0.85	Ω	VGS=10V. ID=4.8A @	
Vas(h)	Gate Threshold Voltage	2.0	_	4.0	V	Vos=Vgs, lo= 250µA	
Qrs .	Forward Transconductance	4.0			S	Vos=50V, 10=4.8A ®	
loss	Drain-to-Source Leakage Current	=	Ξ	25 2 50	μА	V _{DS} =500V, V _{GS} =0V V _{DS} =400V, V _{GS} =0V, T _J =125°	
<u> </u>	Gate-to-Source Forward Leakage	T-	_	100	nA	V _{GS} =20V	
less	Gate-to-Source Reverse Leakage	_		-100	IIA.	Vas=-20V	
Q ₀	Total Gate Charge	j		39		lo=8.0A	
Q _{cs}	Gale-to-Source Charge	i =		10	าต	Vos=40CV	
Q _{od}	Gate-to-Drain ("Miller") Charge		-	19		Vgs=10V See Fig. 5 and 13 8	
t _{dian)}	Turn-On Delay Time		12	_	.!	V _{DD} =250V	
۲	Rise Time	L-	25	_	ns .	In=8.0A	
to(otr)	Turn-Off Delay Time	_	27			R _G =9.1Ω	
¥	Fall Time	_	19	_		Ro=30Ω See Figure 10 @	
Lo	Internal Drain Inductance	-	4.5	_	· nH	Between lead, 6 mm (0.25in.)	
Ls	Internal Source Inductance	_	7.5			from package and center of die contact	
Cas Input Capacitance			1100			V _{GS} =0V	
Cass	Output Capacitance		170		oF.	V _{DS} = 25V	
Cres	Reverse Transfer Capacitance		18		1	'-1.0MHz See Figure 5	

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current (Body Diode)	-	-	8.0		MOSFET symbol showing the integral reverse p-n junction diode.
IsM	Pulsed Source Current (Body Diode) ①	-	-	28	^	
VsD	Diode Forward Voltage		_	2.0	V	T_=25°C, Is=8.0A, VGS=0V &
1,,	Reverse Recovery Time		490	740	ns	T.=25°C. I==8.0A
Q _{rr}	Reverse Recovery Charge	_	3.0	4.5	μC	di/dt=100A/µs ③
lon	Forward Turn-On Time	Intrinsic turn-on time is neglegible (turn-on is dominated by Ls+Ln)				

Notes:

- Repetitive rating; pulse width limited by max, junction temperature (See Figure 11)
- ③ Isp≤8.0A, di/dt≤100A/µs, Vpp≤V(BR)Dss. TJ≤150°C
- VD0=50V, starting T_J=25°C, L=14mH
 RG=25Ω, I_{AS}=8.0A (See Figure 12)
- ④ Pulse width ≤ 300 µs; duty cycle ≤2%.

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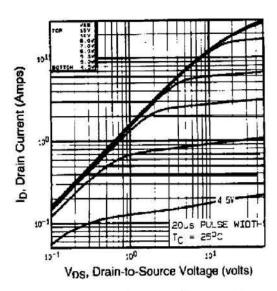


Fig 1. Typical Output Characteristics. Tc=25°C

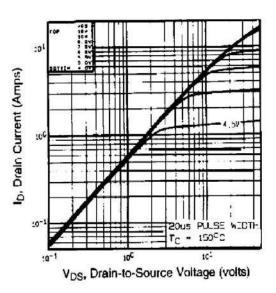


Fig 2. Typical Output Characteristics, Tc=150°C

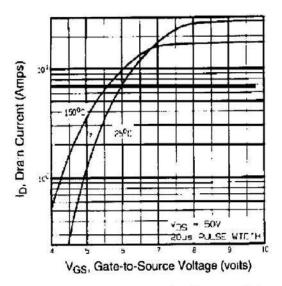


Fig 3. Typical Transfer Characteristics

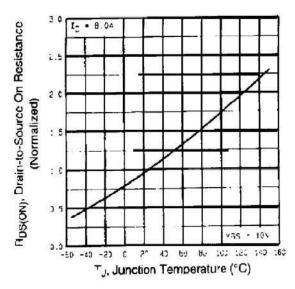


Fig 4. Normalized On-Resistance Vs. Temperature

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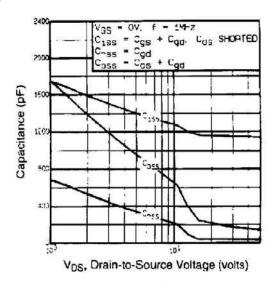


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

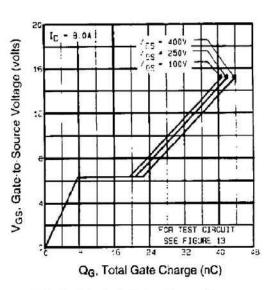


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

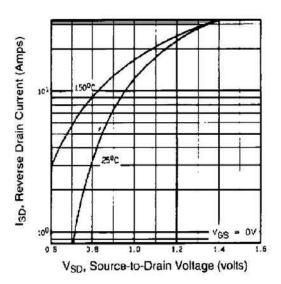


Fig 7. Typical Source-Drain Diode Forward Voltage

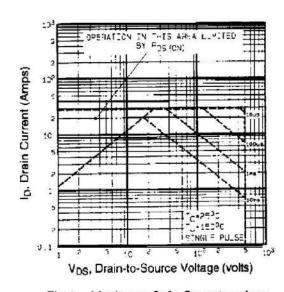


Fig 8. Maximum Safe Operating Area

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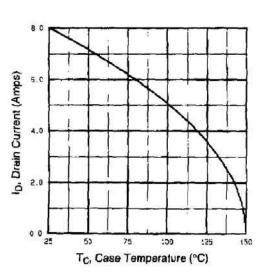


Fig 9. Maximum Drain Current Vs. Case Temperature

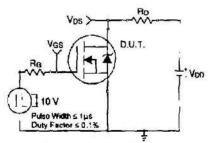


Fig 10a. Switching Time Test Circuit

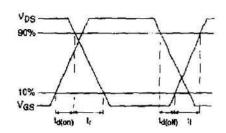


Fig 10b. Switching Time Waveforms

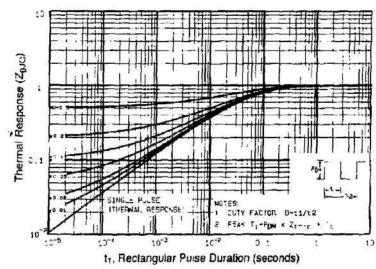


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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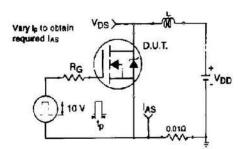


Fig 12a. Unclamped Inductive Test Circuit

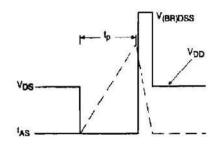


Fig 12b. Unclamped Inductive Waveforms

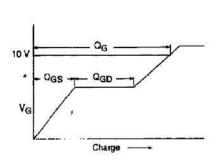


Fig 13a. Basic Gate Charge Waveform

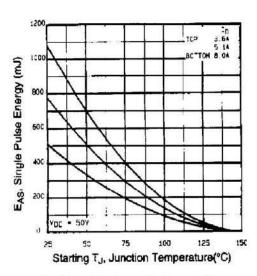


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

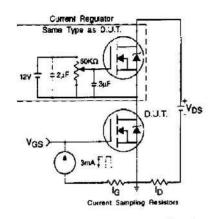


Fig 13b. Gate Charge Test Circuit

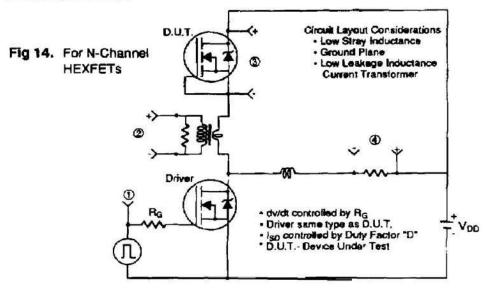
Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit

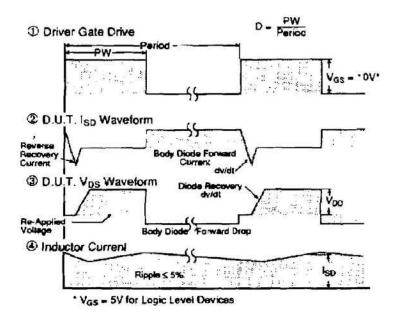
Appendix B: Package Outline Mechanical Drawing

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Appendix A

Peak Diode Recovery dv/dt Test Circuit



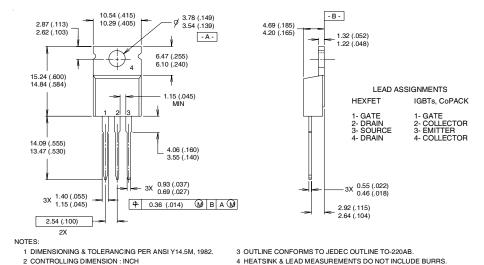


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TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



TO-220AB Part Marking Information

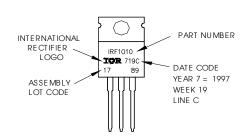
EXAMPLE: THIS IS AN IRF1010

LOT CODE 1789

ASSEMBLED ON WW 19, 1997

IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.



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